

Rochester Electronics Manufactured Components

Rochester branded components are manufactured using either die/wafers purchased from the original suppliers or Rochester wafers recreated from the original IP. All recreations are done with the approval of the OCM.

Parts are tested using original factory test programs or Rochester developed test solutions to guarantee product meets or exceed the OCM data sheet.

Quality Overview

- ISO-9001
- AS9120 certification
- Qualified Manufacturers List (QML) MIL-PRF-35835
 - Class Q Military
 - Class V Space Level
- Qualified Suppliers List of Distributors (QSLD)

• Rochester is a critical supplier to DLA and meets all industry and DLA standards.

Rochester Electronics, LLC is committed to supplying products that satisfy customer expectations for quality and are equal to those originally supplied by industry manufacturers.

The original manufacturer's datasheet accompanying this document reflects the performance and specifications of the Rochester manufactured version of this device. Rochester Electronics guarantees the performance of its semiconductor products to the original OEM specifications. 'Typical' values are for reference purposes only. Certain minimum or maximum ratings may be based on product characterization, design, simulation, or sample testing.

Hex D Master/Slave Flip-Flop

The MC10176 contains six high-speed, master slave type "D" flip-flops. Clocking is common to all six flip-flops. Data is entered into the master when the clock is low. Master to slave data transfer takes place on the positive-going Clock transition. Thus, outputs may change only on a positive-going Clock transition. A change in the information present at the data (D) input will not affect the output information any other time due to the master-slave construction of this device.

• $P_D = 460 \text{ mW typ/pkg}$ (No Load)



MARKING

DIAGRAMS

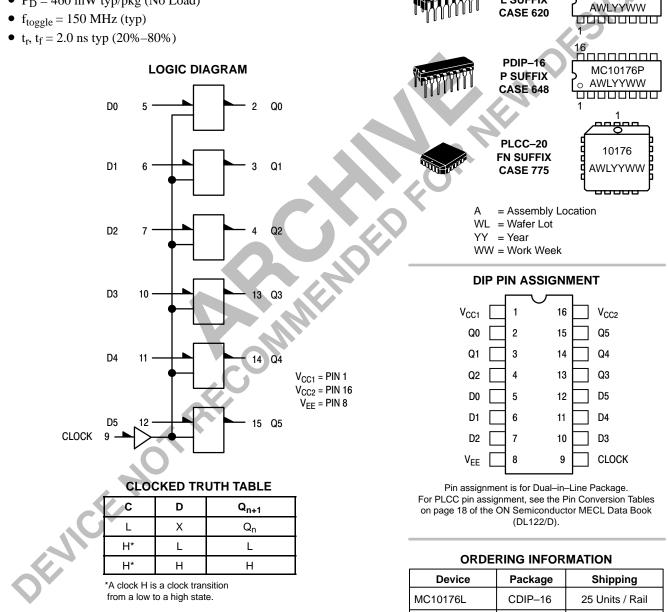
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MC10176L

16

CDIP-16

L SUFFIX



25 Units / Rail

46 Units / Rail

PDIP-16

PLCC-20

MC10176P

MC10176FN

ELECTRICAL CHARACTERISTICS

		Din		Test Limits)	2500		-	
		Pin Under	–30°C		+25°C			+85		4
Characteristic	Symbol	Test	Min	Max	Min	Тур	Max	Min	Max	Un
Power Supply Drain Current	Ι _Ε	8		121		88	110		121	mAc
Input Current	l _{inH}	5 9		350 495			220 310		220 310	μΑσ
	l _{inL}	5 9	0.5 0.5		0.5 0.5			0.3 0.3		μAc
Output Voltage Logic 1	V _{OH}	2† 15†	-1.060 -1.060	-0.890 -0.890	-0.960 -0.960		-0.810 -0.810	-0.890 -0.890	-0.700 -0.700	Vd
Output Voltage Logic 0	V _{OL}	2† 15†	-1.890 -1.890	-1.675 -1.675	-1.850 -1.850		-1.650 -1.650	-1.825 -1.825	-1.615 -1.615	Vde
Threshold Voltage Logic 1	V _{OHA}	2† 15†	-1.080 -1.080		-0.980 -0.980			-0.910 -0.910		Vd
Threshold Voltage Logic 0	V _{OLA}	2† 15†		-1.655 -1.655			-1.630 -1.630		-1.595 -1.595	Vd
Switching Times (50Ω Load) Clock Input										ns
Propagation Delay	t ₉₊₂₊ t _{9+2–}	2 2	1.6 1.6	4.6 4.6	1.6 1.6		4.5 4.5	1.6 1.6	5.0 5.0	
Rise Time (20 to 80%)	t ₂₊	2	1.0	4.1	1.1		4.0	1.1	4.4	
Fall Time (20 to 80%)	t ₂₋	2	1.0	4.1	1.1		4.0	1.1	4.4	
Setup Time	t _{setup}	2	2.5		2.5		-	2.5		ns
Hold Time	t _{hold}	2	1.5		1.5			1.5		ns
Toggle Frequency (Max)	f _{tog}	2	125		125	150		125		MH
			een applied				— — V _{ILn}			

http://onsemi.com 2

ELECTRICAL CHARACTERISTICS (continued)

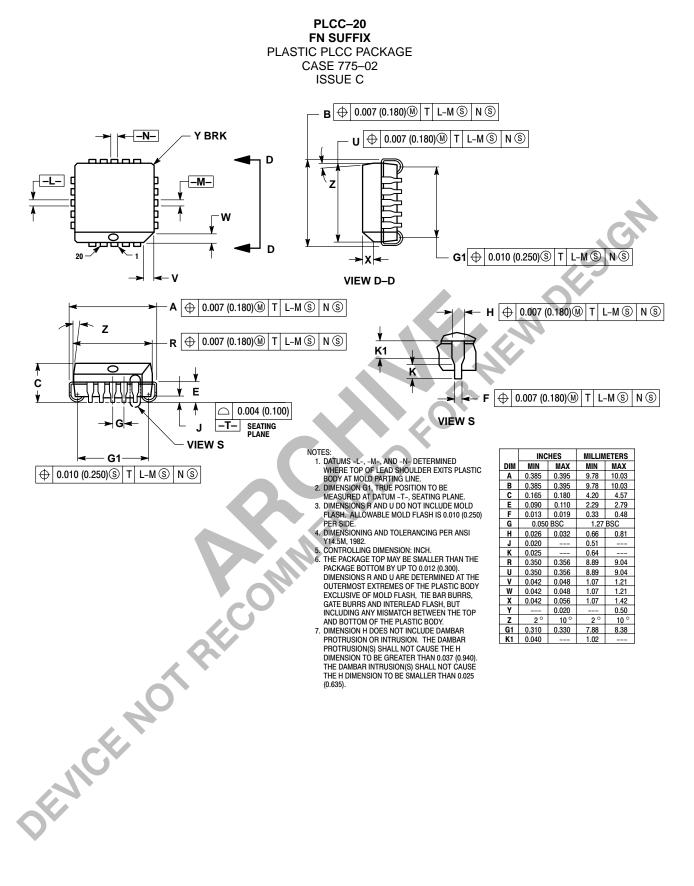
		TEST VOLTAGE VALUES (Volts)							
		@ Test Te	mperature	V _{IHmax}	V _{ILmin}	V _{IHAmin}	V _{ILAmax}	V _{EE}	
			–30°C	-0.890	-1.890	-1.205	-1.500	-5.2	
			+25°C	-0.810	-1.850	-1.105	-1.475	-5.2	
			+85°C	-0.700	-1.825	-1.035	-1.440	-5.2	
			Pin	TEST VOLTAGE APPLIED TO PINS LISTED BELOW					<i></i>
Characteristic		Symbol	Under Test	V _{IHmax}	V _{ILmin}	V _{IHAmin}	V _{ILAmax}	V _{EE}	(V _{CC}) Gnd
Power Supply Drain Current		Ι _Ε	8					8	1, 16
Input Current		l _{inH}	5 9	5 9				8 8	1, 16 1, 16
		l _{inL}	5 9		5 9			8 8	1, 16 1, 16
Output Voltage	Logic 1	V _{OH}	2† 15†	5 12				8 8	1, 16 1, 16
Output Voltage	Logic 0	V _{OL}	2† 15†		5 12			8 8	1, 16 1, 16
Threshold Voltage	Logic 1	V _{OHA}	2† 15†			5 12		8 8	1, 16 1, 16
Threshold Voltage	Logic 0	V _{OLA}	2† 15†				5 12	8 8	1, 16 1, 16
Switching Times (50	Ω Load)			+1.11Vdc	+0.31V	Pulse In	Pulse Out	–3.2 V	+2.0 V
Clock Input Propagatio	n Delay	t ₉₊₂₊ t ₉₊₂₋	2 2			5, 9 5, 9	2 2	8 8	1, 16 1, 16
Rise Time (20	to 80%)	t ₂₊	2			5, 9	2	8	1, 16
Fall Time (20	to 80%)	t ₂₋	2			5, 9	2	8	1, 16
Setup Time		t _{setup}	2			5, 9	2	8	1, 16
Hold Time		t _{hold}	2			5, 9	2	8	1, 16
Toggle Frequency (Max)		f _{tog}	2					8	1, 16

† Output level to be measured after a clock pulse has been applied to the C Input (Pin 9)

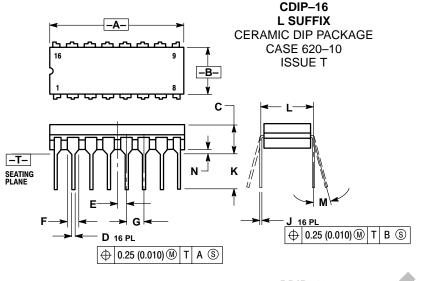
· — V_{IHmax}

Each MECL 10,000 series circuit has been designed to meet the dc specifications shown in the test table, after thermal equilibilum has been established. The circuit is in a test socket or mounted on a printed circuit board and transverse air flow greater than 500 linear fpm is maintained. Outputs are terminated through a 50-ohm resistor to -2.0 volts. Test procedures are shown for only one gate. The other gates are tested in the same manner.

PACKAGE DIMENSIONS



PACKAGE DIMENSIONS



NOTES:

DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
CONTROLLING DIMENSION: INCH.
DIMENSION L TO CENTER OF LEAD WHEN FOOMED DRAWLES

DIMENSION LTO CENTER OF LEAD WHEN FORMED PARALLEL.
DIMENSION F MAY NARROW TO 0.76 (0.030) WHERE THE LEAD ENTERS THE CERAMIC BODY.

	INC	HES	MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	0.750	0.785	19.05	19.93	
В	0.240	0.295	6.10	7.49	
С		0.200		5.08	
D	0.015	0.020	0.39	0.50	
Е	0.050 BSC		1.27 BSC		
F	0.055	0.065	1.40	1.65	
G	0.100 BSC		2.54 BSC		
Н	0.008	0.015	0.21	0.38	
κ	0.125	0.170	3.18	4.31	
Г	0.300 BSC		7.62 BSC		
Μ	0 °	15 °	0 °	15°	
Ν	0.020	0.040	0.51	1.01	

-A-<u>ሳ ስ ስ ስ</u> 16 в 0 L $\Box \Box$ ι, հո С S -T- SEATING PLANE H G **D** 16 PL

PDIP-16 **P SUFFIX** PLASTIC DIP PACKAGE CASE 648-08 ISSUE R

NOTES: 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH. 3. DIMENSION L TO CENTER OF LEADS WHEN FORMED PARALLEL. 4. DIMENSION B DOES NOT INCLUDE MOLD FLASH. 5. ROUNDED CORNERS OPTIONAL

		INC	HES	MILLIMETERS		
D	IM	MIN	MAX	MIN	MAX	
	Α	0.740	0.770	18.80	19.55	
	В	0.250	0.270	6.35	6.85	
	C	0.145	0.175	3.69	4.44	
	D	0.015	0.021	0.39	0.53	
	F	0.040	0.70	1.02	1.77	
	G	0.100	BSC	2.54 BSC		
	H	0.050	BSC	1.27 BSC		
	J	0.008	0.015	0.21	0.38	
1	Κ	0.110	0.130	2.80	3.30	
	L	0.295	0.305	7.50	7.74	
	М	0°	10 °	0 °	10 °	
	S	0.020	0.040	0.51	1.01	

Notes

Notes

DEWCE NOT RECOMMENDED FOR MENDESIGN

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